

<b>Notice of References Cited</b>	Application/Control No. 10/723,248		Applicant(s)/Patent Under Reexamination ARRAMON, YVES P.	
	Examiner DEVANIE DUFOUR		Art Unit 3733	Page 1 of 1

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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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